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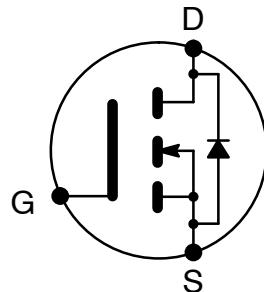
## NTE67 MOSFET N-Ch, Enhancement Mode High Speed Switch

### Description:

The NTE67 is a TMOS Power FET in a TO220 type package designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

### Features:

- Lower  $R_{DS(ON)}$
- Improved Inductive Ruggedness
- Fast Switching Times
- Lower Input Capacitance
- Extended Safe Operating Area
- Improved High Temperature Reliability



### Absolute Maximum Ratings:

Drain–Source Voltage ( $T_J = +25^\circ\text{C}$ to $+150^\circ\text{C}$ ), $V_{DSS}$ .....	400V
Drain–Gate Voltage ( $R_{GS} = 1\text{M}\pm$ , $T_J = +25^\circ\text{C}$ to $+125^\circ\text{C}$ ), $V_{DGR}$ .....	400V
Gate–Source Voltage, $V_{GS}$ .....	$\pm 20\text{V}$
Continuous Drain Current, $I_D$	
$T_C = +25^\circ\text{C}$ .....	4.5A
$T_C = +100^\circ\text{C}$ .....	3.0A
Pulsed Drain Current (Note 2), $I_{DM}$ .....	18A
Pulsed Gate Current, $I_{GM}$ .....	$\pm 1.5\text{A}$
Single Pulsed Avalanche Energy (Note 3), $E_{AS}$ .....	290mJ
Avalanche Current, $I_{AS}$ .....	5.5A
Total Power Dissipation ( $T_C = +25^\circ\text{C}$ ), $P_D$ .....	75W
Derate Above $25^\circ\text{C}$ .....	$0.6\text{W}/^\circ\text{C}$
Operating Junction Temperature Range, $T_J$ .....	$-55^\circ$ to $+150^\circ\text{C}$
Storage Temperature Range, $T_{stg}$ .....	$-55^\circ$ to $+150^\circ\text{C}$
Lead Temperature (During Soldering, 1/8" from case, 5sec max.), $T_L$ .....	$+300^\circ\text{C}$
Thermal Resistance, Junction-to-Case, $R_{thJC}$ .....	1.67K/W
Thermal Resistance, Junction-to-Ambient, $R_{thJA}$ .....	80K/W
Thermal Resistance, Case-to-Sink (Mounting surface flat, smooth, and greased), $R_{thcs}$	0.24K/W

Note 1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

Note 2. Repetitive rating: Pulse width limited by max. junction temperature.

Note 3.  $L = 17\text{mH}$ ,  $V_{dd} = 50\text{V}$ ,  $R_G = 25\pm$ , Starting  $T_J = +25^\circ\text{C}$ .

**Electrical Characteristics:** ( $T_C = +25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\text{mA}$	400	—	—	V
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\text{mA}$	2.0	—	4.0	V
Gate-Source Leakage, Forward	$I_{\text{GSS}}$	$V_{\text{GS}} = 20\text{V}$	—	—	100	nA
Gate-Source Leakage, Reverse	$I_{\text{GSS}}$	$V_{\text{GS}} = -20\text{V}$	—	—	-100	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = \text{Max. Rating}, V_{\text{GS}} = 0\text{V}$	—	—	250	$\text{mA}$
		$V_{\text{DS}} = \text{Max. Rating} \times 0.8, V_{\text{GS}} = 0\text{V}, T_C = +125^\circ\text{C}$	—	—	1000	$\text{mA}$
On-State Drain-Source Current	$I_{\text{D(on)}}$	$V_{\text{DS}} > I_{\text{D(on)}} \times R_{\text{DS(on)}}^{\text{max}}, V_{\text{GS}} = 10\text{V}$ , Note 1	4.5	—	—	A
Static Drain-Source On-State Resistance	$R_{\text{DS(on)}}$	$V_{\text{GS}} = 10\text{V}, I_D = 3\text{A}$ , Note 1	—	1.0	1.5	$\pm$
Forward Transconductance	$g_{\text{fs}}$	$V_{\text{DS}} \geq 50\text{V}, I_D = 3\text{A}$ , Note 1	2.9	4.4	—	mhos
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 25\text{V}, f = 1\text{MHz}$	—	780	—	pF
Output Capacitance	$C_{\text{oss}}$		—	99	—	pF
Reverse Transfer Capacitance	$C_{\text{rss}}$		—	43	—	pF
Turn-On Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}} = 0.5\text{BV}_{\text{DSS}}, I_D = 5.5\text{A}, Z_O = 12\pm$ (MOSFET switching times are essentially independent of operating temperature)	—	11	17	ns
Rise Time	$t_r$		—	19	29	ns
Turn-Off Delay Time	$t_{\text{d(off)}}$		—	37	56	ns
Fall Time	$t_f$		—	16	24	ns
Total Gate Charge (Gate-Source Plus Gate-Drain)	$Q_g$	$V_{\text{GS}} = 10\text{V}, I_D = 5.5\text{A}, V_{\text{DS}} = 0.8 \text{ Max. Rating}$ (Gate charge is essentially independent of operating temperature)	—	18	30	nC
Gate-Source Charge	$Q_{\text{gs}}$		—	40	—	nC
Gate-Drain ("Miller") Charge	$Q_{\text{gd}}$		—	14	—	nC

Note 1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

**Source-Drain Diode Ratings and Characteristics:**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Continuous Source Current (Body Diode)	$I_S$		—	—	4.5	A
Pulse Source Current (Body Diode)	$I_{\text{SM}}$	Note 2	—	—	18	A
Diode Forward Voltage	$V_{\text{SD}}$	$T_C = +25^\circ\text{C}, I_S = 4.5\text{A}, V_{\text{GS}} = 0\text{V}$	—	—	1.6	V
Reverse Recovery Time	$t_{\text{rr}}$	$T_J = +25^\circ\text{C}, I_F = 5.5\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$	—	310	660	ns

Note 1. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

Note 2. Repetitive rating: Pulse width limited by max. junction temperature.

